

NIOSH Public Meeting Attendees
March 30, 2009
Los Angeles, CA

QA Meeting Attendee	Company	Address	Phone	E-mail	Presenting?
Handeland, Diane	3M				
Antunes, Will	SCI				
Tecon, Pierre	SCI				
Lesiecki, Patrick	SCI				
Negus, Ted	Allegro				
Podlogar, Bob	ICS Labs				
Birkner, Jeffrey S.	Moldex-Metric, Inc.				
Stewart, James	NIST				
Wawrzyniak, William	Moldex-Metric, Inc.				
Aviles, William	Sperian				

NIOSH ATTENDEES:

Rehak, Tim
 Newcomb, Bill
 Katz, Ted
 Kiefer, Max

Inabnet, Joe Inabnet Reporting Services